

## 1.8-V ANALOG SUPPLY, 10-BIT, 65/40 MSPS <br> ANALOG-TO-DIGITAL CONVERTERS WITH INTERNAL REFERENCE

## FEATURES

- ADS5102 (65 MSPS) ADS5103 (40 MSPS)
- Differential Input
- 1.8 V Analog/Digital Supply
- Digital Outputs Compatible With 1.8 V or 3.3 V Logic
- Signal-to-Noise: 58 dB at 20 MHz (ADS5103)
- Spurious Free Dynamic Range: 71 dB at 20 MHz (ADS5102)
- 105-mW Power Dissipation (ADS5103)
- $336 \mu$ W Power-Down Mode


## APPLICATIONS

- Ultrasound
- Digital Cameras


## - Imaging

- Communications
- Baseband Digitization


## DESCRIPTION

The ADS5102/3 are low-power CMOS, 10-bit, analog-to-digital converters (ADC) that operate from a single $1.8-\mathrm{V}$ supply. The internal reference can be bypassed to use an external reference to suit the dc accuracy and temperature drift requirements of the application. A 10 -bit parallel output data bus is provided with 3 -state outputs. For power sensitive systems, a standby mode is provided which reduces power consumption to $336 \mu \mathrm{~W}$. Also, if using external voltage reference, then the internal VREF circuit can be powered down. The analog input is differential, which provides excellent common-mode noise rejection as well as superior performance from the ADS5102/3.

## FUNCTIONAL BLOCK DIAGRAM



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.


NC - No internal connection
ORDERING INFORMATION

| $\mathbf{T}_{\mathbf{A}}$ | 48-TQFP (PFB) <br> Tape and Reel | 48-TQFP (PFB) <br> Tray | 48-TQFP (PFB) <br> Tape and Reel | 48-TQFP (PFB) <br> Tray |
| :--- | :--- | :---: | :---: | :---: |
|  | 40 MSPS | 40 MSPS | 65 MSPS | 65 MSPS |
| $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ | ADS5103CPFBR | ADS5103CPFB | ADS5102CPFBR | ADS5102CPFB |
| $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | ADS5103IPFBR | ADS5103IPFB | ADS5102IPFBR | ADS5102IPFB |
| Evaluation module | ADS5103EVM | ADS5103EVM | ADS5102EVM | ADS5102EVM |

## Terminal Functions

| TERMINAL |  | I/O | DESCRIPTION |
| :---: | :---: | :---: | :---: |
| NAME | NO. |  |  |
| $\mathrm{AV}_{\mathrm{DD}}$ | 2, 41, 46 | 1 | Analog supply, 1.8V $\pm 5 \%$ |
| AGND | 3, 9, 42, 45 | 1 | Analog ground |
| REFT | 4 | 1/O | Reference top |
| REFB | 5 | I/O | Reference bottom |
| CML | 6 | 0 | Common mode level output-nominally 1.0 V |
| BG | 7 | 0 | Band-gap decoupling-decouple with $1 \mu \mathrm{~F}$ to GND and $100 \mathrm{k} \Omega$ to $\mathrm{AV}_{\text {DD }}$ (refer to Figure 30) |
| PDREF | 17 | I | Powerdown reference when using external voltage reference $0=$ internal VREF, 1 = external VREF. In external VREF mode, connect pins BG and REFT together. |
| RBIAS | 14 | 0 | Connect a resistor between this pin and AGND. This resistor value is determined by speed grade selected and is used to set amplifier internal bias currents. (see Table 2) |
| $\overline{\mathrm{OE}}$ | 18 | 1 | 1 = 3 -state the data outputs, $0=$ data bus enable |
| $\overline{\text { STBY }}$ | 19 | 1 | $0=$ power down mode, $1=$ normal operation mode |
| CLK | 20 | 1 | Clock Input |
| DGND | 21, 40 | 1 | Digital ground |
| DVDD | 22, 39 | 1 | Digital supply-1.8 V nominally |
| DRV DD | 24 | 1 | Driver digital supply-1.8 V or 3.3 V nominally |
| D9 | 25 | 0 | Digital Bit 9 (MSB) |
| D8 | 26 | 0 | Digital Bit 8 |
| D7 | 27 | 0 | Digital Bit 7 |
| D6 | 28 | 0 | Digital Bit 6 |
| D5 | 29 | 0 | Digital Bit 5 |
| D4 | 30 | 0 | Digital Bit 4 |
| D3 | 31 | 0 | Digital Bit 3 |
| D2 | 32 | 0 | Digital Bit 2 |
| D1 | 33 | 0 | Digital Bit 1 |
| D0 | 34 | 0 | Digital Bit 0 (LSB) |
| DRGND | 37 | 1 | Driver digital ground |
| AIN+ | 44 | 1 | Positive analog input |
| AIN- | 43 | 1 | Negative analog input |
| NC | $\begin{gathered} \hline 1,8,10,11,12, \\ 13,15,16,23,35, \\ 36,38,47,48 \end{gathered}$ | NA | No internal connection on this pin |

## absolute maximum ratings over operating free-air temperature (unless otherwise noted) $\dagger$



## recommended operating conditions

|  |  | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Analog Inputs |  |  |  |  |  |
| Analog input voltage (AIN+, AIN-) |  | REFB |  | REFT | V |
| Input voltage, differential full scale |  |  | 1 |  | $\mathrm{V}_{\mathrm{pp}}$ |
| Input common-mode voltage, (REFT+ | EFB)/2 | 0.8 |  | 1.1 | V |
| Input capacitance ( $\mathrm{C}_{\mathrm{i}}$ ), measured to g | und |  | 5 |  | pF |
| Overvoltage recovery time, 1.8-V input | voltage |  | 10 |  | ns |
| Analog input bandwidth |  |  | 950 |  | MHz |
|  | ADS5102 |  | 38.5 |  |  |
| Input impedance (switch capacitor) | ADS5103 |  | 62.5 |  | $\mathrm{k} \Omega$ |
| Supplies and References |  |  |  |  |  |
| Operating free-air temperature, $\mathrm{T}_{\mathrm{A}}$ |  | -40 |  | 85 | ${ }^{\circ} \mathrm{C}$ |
| Analog supply voltage, AV DD |  | 1.65 | 1.80 | 2.00 | V |
| Digital supply voltage, $\mathrm{DV}_{\text {DD }}$ |  | 1.65 | 1.80 | 2.00 | V |
| Digital driver supply voltage, $\mathrm{DRV}_{\text {DD }}$ |  | 1.65 | 1.80 | 3.6 | V |
| Reference top voltage, VREFT |  | 1.30 | 1.34 | 1.39 | V |
| Reference bottom voltage, VREFB |  | 0.78 | 0.81 | 0.84 | V |
| Common-mode voltage, VCML |  | 0.85 | 1.05 | 1.15 | V |
| Bandgap voltage, VBG |  | 1.22 | 1.27 | 1.32 | V |
| Clock Inputs CLK |  |  |  |  |  |
|  | ADS5102 | 1 |  | 65 |  |
| Sampling rate | ADS5103 | 1 |  | 40 | MSPS |

electrical characteristics over recommended operating conditions, $A V_{D D}=D V_{D D}=1.8 \mathrm{~V}$, $D R V_{D D}=3.3 \mathrm{~V}, \mathrm{~F}_{\mathrm{S}}=40,65 \mathrm{MSPS}$ (as appropriate) $/ 50 \%$ duty cycle, -1 dBFS input span, $\mathrm{C}_{\mathrm{L}}=10 \mathrm{pF}$ at D0-D9, internal reference, $T_{(\min )}$ to $T_{(\max )}$, typical data at $25^{\circ} \mathrm{C}$ (unless otherwise noted)
internal reference voltages

|  |  | PARAMETER | MIN | TYP | MAX |
| :--- | :--- | ---: | ---: | :---: | :---: |
| UNIT |  |  |  |  |  |
| VREFT | Reference top voltage | 1.30 | 1.34 | 1.39 | V |
| VREFB | Reference bottom voltage | 0.78 | 0.81 | 0.84 | V |
| VCML | Common-mode voltage | 0.85 | 1.05 | 1.15 | V |
| VBG | Bandgap voltage | 1.22 | 1.27 | 1.32 | V |

## external reference voltages

|  | PARAMETER | MIN | TYP | MAX | UNIT |
| :--- | :--- | ---: | ---: | :---: | :---: |
| REFT | Reference input voltage (top) | 1.15 | 1.25 | 1.35 | V |
| REFB | Reference input voltage (bottom) | 0.70 | 0.75 | 0.85 | V |
| REFT-REFB | Differential input | 0.45 | 0.50 | 0.55 | V |
|  | Input resistance |  | 200 | $\Omega$ |  |

## digital outputs

|  | PARAMETER | TEST CONDITIONS |  | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | High-level output voltage | $\mathrm{IOH}=50 \mu \mathrm{~A}$ | $\mathrm{DRV}^{\text {DD }}=1.8 \mathrm{~V}$ | $\mathrm{DRV}_{\text {DD }}-0.1$ |  |  | V |
|  |  |  | $\mathrm{DRV}^{\text {DD }}=3.3 \mathrm{~V}$ | DRV ${ }_{\text {DD }}-0.2$ |  |  |  |
| VOL | Low-level output voltage | $\mathrm{IOL}=50 \mu \mathrm{~A}$ | $\mathrm{DRV}^{\text {DD }}=1.8 \mathrm{~V}$ |  |  | 0.1 | V |
|  |  |  | $\mathrm{DRV}_{\mathrm{DD}}=3.3 \mathrm{~V}$ |  |  | 0.2 |  |
| $\mathrm{C}_{\mathrm{L}}$ | External load capacitance |  |  |  | 15 |  | pF |

digital inputs

|  | PARAMETER | TEST CONDITIONS | MIN | TYP MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{IH}}$ | High-level input voltage | DRV ${ }_{\text {DD }}=1.8 \mathrm{~V}$ | $0.8 \times \mathrm{DRV}_{\text {DD }}$ |  | V |
|  |  | DRV ${ }_{\text {DD }}=3.3 \mathrm{~V}$ | $0.8 \times \mathrm{DRV}_{\text {DD }}$ |  |  |
| $\mathrm{V}_{\mathrm{IL}}$ | Low-level input voltage | $\mathrm{DRV}_{\text {DD }}=1.8 \mathrm{~V}$ |  | $0.2 \times \mathrm{DRV}_{\text {DD }}$ | V |
|  |  | $\mathrm{DRV}_{\text {DD }}=3.3 \mathrm{~V}$ |  | $0.2 \times$ DRV ${ }_{\text {DD }}$ |  |
| ${ }_{1 / \mathrm{H}}$ | High-level input current | $\mathrm{V}_{\mathrm{IH}}=\mathrm{DRV} \mathrm{V}_{\text {D }}$ |  | $\pm 5$ | $\mu \mathrm{A}$ |
| IIL | Low-level input current | $\mathrm{V}_{\text {IL }}=0 \mathrm{~V}$ |  | $\pm 5$ | $\mu \mathrm{A}$ |

## dc accuracy

| PARAMETER |  |  | TEST CONDITIONS | MIN TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| (INL) | Integral nonlinearity | ADS5102 |  | $\pm 1$ | $\pm 2.5$ | LSB |
|  |  | ADS5103 |  | $\pm 0.5$ | $\pm 1.5$ | LSB |
| (DNL) | Differential nonlinearity | ADS5102 |  | $\pm 0.5$ | $\pm 1$ | LSB |
|  |  | ADS5103 |  | $\pm 0.4$ | $\pm 0.8$ | LSB |
|  | Missing code |  |  | No missing code assured |  |  |
|  | Offset error |  | REFT $=1.25 \mathrm{~V}, \mathrm{REFB}=0.75 \mathrm{~V}$ | $\pm 0.4$ | $\pm 1.5$ | \%FSR |
|  | Gain error |  | REFT $=1.25 \mathrm{~V}, \mathrm{REFB}=0.75 \mathrm{~V}$ | $\pm 1.4$ | $\pm 2$ | \%FSR |

ADS5102
ADS5103
SLAS351B-OCToBER 2001 - REVIISED DECEMBER 2001
electrical characteristics over recommended operating conditions, $A V_{D D}=D V_{D D}=1.8 \mathrm{~V}$, $D R V_{D D}=3.3 \mathrm{~V}, \mathrm{~F}_{\mathrm{S}}=40,65 \mathrm{MSPS}$ (as appropriate)/ $50 \%$ duty cycle, -1 dBFS input span, $\mathrm{C}_{\mathrm{L}}=10 \mathrm{pF}$ at D0-D9, internal reference, $\mathrm{T}_{(\min )}$ to $\mathrm{T}_{(\max )}$, typical data at $25^{\circ} \mathrm{C}$ (unless otherwise noted) (continued)

## dynamic performance

| PARAMETER |  |  | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ENOB | Effective number of bits | ADS5102 | $\mathrm{f}=3.5 \mathrm{MHz}$ | 8.7 | 9.2 |  | Bits |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | 9 |  |  |
|  |  | ADS5103 | $\mathrm{f}=3.5 \mathrm{MHz}$ | 9.0 | 9.3 |  | Bits |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | 9.2 |  |  |
| SFDR | Spurious free dynamic range | ADS5102 | $\mathrm{f}=3.5 \mathrm{MHz}$ | 58 | 73 |  | dBc |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | 71 |  |  |
|  |  | ADS5103 | $\mathrm{f}=3.5 \mathrm{MHz}$ | 64 | 69 |  | dBc |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | 66 |  |  |
| THD | Total harmonic distortion | ADS5102 | $\mathrm{f}=3.5 \mathrm{MHz}$ |  | -71 | -55 | dBc |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | -71 |  |  |
|  |  | ADS5103 | $\mathrm{f}=3.5 \mathrm{MHz}$ |  | -65 | -62 | dBc |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | -68 |  |  |
| SNR | Signal-to-noise ratio | ADS5102 | $\mathrm{f}=3.5 \mathrm{MHz}$ | 56 | 58 |  | dBc |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | 57 |  |  |
|  |  | ADS5103 | $\mathrm{f}=3.5 \mathrm{MHz}$ | 57 | 59 |  | dBc |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | 58 |  |  |
| SINAD | Signal-to-noise and distortion | ADS5102 | $\mathrm{f}=3.5 \mathrm{MHz}$ | 54 | 58 |  | dBc |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | 57 |  |  |
|  |  | ADS5103 | $\mathrm{f}=3.5 \mathrm{MHz}$ | 56 | 58 |  | dBc |
|  |  |  | $\mathrm{f}=20 \mathrm{MHz}$ |  | 57 |  |  |

power supply $\dagger$

| PARAMETER |  |  | TEST CONDITIONS |  | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Operating voltage | AV ${ }_{\text {DD }}$ |  |  | 1.65 | 1.8 | 2 | V |
|  |  | DVDD |  |  | 1.65 | 1.8 | 2 |  |
|  |  | DRV ${ }_{\text {DD }}$ |  |  | 1.65 | 1.8 | 3.6 |  |
| $\mathrm{I}\left(\mathrm{AV}_{\mathrm{DD}}\right)$ | Analog supply current | ADS5102 | $A V_{D D}=V^{\text {d }}$ ( $=1.8 \mathrm{~V}$, | $D R V_{D D}=3.3 \mathrm{~V}$ |  | 70 | 80 | mA |
|  |  | ADS5103 |  |  |  | 45 | 53 |  |
| I(DVDD) | Digital supply current | ADS5102 | $A V_{D D}=V^{\text {d }}$ ( $=1.8 \mathrm{~V}$, | DRV ${ }_{\text {D }}=3.3 \mathrm{~V}$ |  | 8 | 9 | mA |
|  |  | ADS5103 |  |  |  | 5 | 7 |  |
| I(DRV ${ }_{\text {DD }}$ ) | Output driver supply current | ADS5102 | $A V_{D D}=\mathrm{DV}^{\text {DD }}=1.8 \mathrm{~V}$, | DRV ${ }_{\text {DD }}=3.3 \mathrm{~V}$ |  | 6.5 | 8 | mA |
|  |  | ADS5103 |  |  |  | 4.8 | 5.5 |  |
| ${ }^{\prime}$ (TOTAL) | Total current consumption | ADS5102 | $A V_{D D}=\mathrm{DV}_{D D}=1.8 \mathrm{~V}$, | $D R V_{D D}=3.3 \mathrm{~V}$ |  | 84 | 97 | mA |
|  |  | ADS5103 |  |  |  | 54 | 66 |  |
| $P_{\text {D }}$ | Power dissipation | ADS5102 | $A V_{D D}=\mathrm{DV}_{D D}=1.8 \mathrm{~V}$, | DRV ${ }_{\text {DD }}=3.3 \mathrm{~V}$ |  | 160 | 188 | mW |
|  |  | ADS5103 |  |  |  | 105 | 126 |  |
|  | Standby power |  | CLK running |  |  | 336 | 390 | $\mu \mathrm{W}$ |
|  | Power supply rejection |  |  |  |  | 0.25 |  | \%FS |

$\dagger$ Sinewave input, $\mathrm{f}_{\mathrm{i}}=3.5 \mathrm{MHz},-1 \mathrm{dBFS}$ input span
electrical characteristics over recommended operating conditions, $A V_{D D}=D V_{D D}=1.8 \mathrm{~V}$, $D R V_{D D}=3.3 \mathrm{~V}, \mathrm{~F}_{\mathrm{S}}=40,65 \mathrm{MSPS}$ (as appropriate) $/ 50 \%$ duty cycle, -1 dBFS input span, $\mathrm{C}_{\mathrm{L}}=10 \mathrm{pF}$ at D0-D9, internal reference, $\mathrm{T}_{(\min )}$ to $\mathrm{T}_{(\max )}$, typical data at $25^{\circ} \mathrm{C}$ (unless otherwise noted) (continued)
timing characteristics

|  | PARAMETER | TEST CONDITIONS | MIN | TYP |
| :--- | :--- | :--- | ---: | :---: |
|  | MAX | UNIT |  |  |
|  | Clock duty cycle |  | $50 \pm 10$ | $\%$ |
| $\mathrm{t}_{\mathrm{d}(\mathrm{o})}$ | Output propagation delay |  | 9 | 12 |
| $\mathrm{t}(\mathrm{en})$ | $\overline{\mathrm{OE}} \downarrow$ to outputs enabled time | ns |  |  |
| $\mathrm{t}_{\text {dis }}$ | $\overline{\mathrm{OE}} \uparrow$ rising to outputs 3 -state disable time |  | 6 | ns |
| $\mathrm{t}_{\mathrm{d}(\text { latency })}$ | Pipeline latency |  | 10 | ns |
| $\mathrm{t}_{\mathrm{d}(\mathrm{ap})}$ | Aperture delay |  | 5.5 | cyc |
|  | Aperture uncertainty |  | 1 | ns |

## timing diagram



## TYPICAL CHARACTERISTICS



Figure 1

ADS5102
DIGITAL SUPPLY CURRENT
vs
TEMPERATURE


Figure 3

ADS5103
ANALOG SUPPLY CURRENT
vs
TEMPERATURE


Figure 2
ADS5103
DIGITAL SUPPLY CURRENT
TEMPERATURE


Figure 4

## TYPICAL CHARACTERISTICS



Figure 7

TYPICAL CHARACTERISTICS

ADS5103
DIFFERENTIAL NONLINEARITY


Figure 8


Figure 9

ADS5103
INTEGRAL NONLINEARITY


Figure 10

## TYPICAL CHARACTERISTICS



Figure 11

ADS5102
SPURIOUS FREE DYNAMIC RANGE
vs
ANALOG INPUT LEVEL


Figure 13

ADS5102
INTERNAL VREF VALUES
vs
TEMPERATURE


Figure 12

ADS5103
SPURIOUS FREE DYNAMIC RANGE vs
ANALOG INPUT LEVEL


Figure 14

## TYPICAL CHARACTERISTICS



Figure 15

ADS5102
SIGNAL-TO-NOISE RATIO
vs
ANALOG INPUT FREQUENCY


Figure 17

ADS5103
TOTAL HARMONIC DISTORTION
VS
ANALOG INPUT FREQUENCY


Figure 16

ADS5103
SIGNAL-TO-NOISE RATIO
ANALOG INPUT FREQUENCY


Figure 18

## TYPICAL CHARACTERISTICS



Figure 19


Figure 21

ADS5103
SIGNAL-TO-NOISE RATIO and DISTORTION vs ANALOG INPUT FREQUENCY


Figure 20

ADS5103
EFFECTIVE NUMBER OF BITS
vs
ANALOG INPUT FREQUENCY


Figure 22

## TYPICAL CHARACTERISTICS



Figure 23
ADS5102
SFDR, SINAD
vs
CLOCK DUTY CYCLE


Figure 25

ADS5103
SPURIOUS FREE DYNAMIC RANGE
vs
ANALOG INPUT FREQUENCY


Figure 24

ADS5103 SFDR, SINAD
vs
CLOCK DUTY CYCLE


Figure 26

## TYPICAL CHARACTERISTICS



## PRINCIPLES OF OPERATION

## analog-to-digital converter

The ADS5102/3 is designed using a switched capacitor pipeline architecture fabricated in CMOS process. The pipeline architecture is implemented with 10 stages, thus allowing for high conversion speed and exceptionally low power. Each of these 10 stages produces one digital bit per stage. Both rising and falling edges of the clock are used so the signal propagates thru the pipeline every half clock or five total clocks. Digital error correction uses another $1 / 2$ clock cycle at the end; thus the total pipeline latency is 5.5 clocks. (Refer to timing diagram on page 7)

## 10-stage operation

The signal is sampled by the SHA. The first stage is digitized by 1.5 bits and sent to the digital error correction block. This digitized value is then applied to a DAC, which recreates the analog value that has been digitized. This value is then fed into a summing junction with the original input signal. The summing junction subtracts the converted value from the original signal. This is known as the residue voltage. This residue voltage is then amplified by a factor of $2 x$ and transferred to the next stage. This is repeated for each of the 10 stages.
Each of the 10 pipeline stages, as well as the sample and hold amplifier, is differential in nature. This allows rejection of any common mode signal. Thus a signal seen on Ain+ and Ain- is differentially seen as 0 V on the output. This fully differential architecture allows higher ac performance of the ADC by reducing noise susceptibility.

## PRINCIPLES OF OPERATION

## analog input sample and hold amplifier circuit

The sample and hold amplifier is implemented using switch capacitor techniques. A simplified functional block diagram is shown in Figure 29. The SHA is in sample mode when CLK is high and in hold mode when CLK is low. In sample mode, the input switches, P1, are closed and the differential input signal is sampled onto caps Cs. An internal common-mode voltage is applied to the sampling caps ( $\mathrm{C}_{\mathrm{s}}$ ) when the two P1P switches are closed. As the CLK falling edge occurs, the SHA is now placed into hold or amplification mode. In this mode, P1 switches are now opened and switches P2 are closed. This is the amplification state and the signal is transferred to the output of the amplifier with a nominal gain of $1 . \mathrm{C}_{\mathrm{L}}$ of Figure 29 represents the load capacitance of the following stage. R-C values of the input determine the analog input bandwidth of the SHA (and therefore the whole ADC) which is 950 MHz for the ADS5102/3. This wide bandwidth assures no distortion to the Nyquist frequency of 32.5 MHz . In under sampling applications, it is common to require the analog input bandwidth to be 5 times greater than the IF Nyquist frequency. As such, the ADS5102/3 supports IF frequencies approaching 200 MHz in under sampling applications.


Figure 29. Simplified Functional Block Diagram
Because the input to the sample and hold amplifier is a switched capacitor circuit, the input resistance is dynamic and based on the sampling rate of the converter. The impedance of each input is defined by the equation:

$$
Z_{I}=\frac{1}{F \times C_{s}}
$$

Where:

$$
\begin{aligned}
& \mathrm{C}_{\mathrm{s}}=\text { Sampling capacitor }=0.4 \mathrm{pF} \text { typical } \\
& \mathrm{F}=\mathrm{CLK} \text { frequency in } \mathrm{Hz}
\end{aligned}
$$

The key for selecting an amplifier to correctly drive the ADS5102/3 is to ensure that the output frequency of the amplifier is much lower than the input impedance of the ADS5102/3, which at 65 MSPS is $38.46 \mathrm{k} \Omega$. For system accuracy comparable to 1 LSB, this means selecting an amplifier with output impedance of $\sim 31 \Omega$ for sampling rates of 65 MSPS.

## reference configurations

The ADS5102/3 provides an internal voltage reference which should be suitable for most 10 bit systems. The typical full scale voltage for the device is determined by VFS = VREFT - VREFB. Since the input is fully differential, the full scale input is twice the single ended value or 1 V differential. It is recommended to externally de-couple both VREFT and VREFB with a $0.1 \mu \mathrm{~F}$ capacitor to bypass all high frequency noise to ground. It is necessary to connect BG and $\mathrm{AV} \mathrm{V}_{\mathrm{DD}}$ with a $100 \mathrm{k} \Omega$ resistor and decouple with a $1 \mu \mathrm{~F}$ capacitor to AGND (refer to Figure 30 for correct configuration).

## PRINCIPLES OF OPERATION



Figure 30. BG Reference Configuration
For systems that require more absolute accuracy or lower temperature coefficient drift than provided by the internal VREF, an external voltage reference can be applied to the VREFB and VREFT inputs. To use external reference, connect the PDREF pin to a logic high and this internally disconnects the VREF from the ADC. In this mode it is also necessary to connect the BG and REFT pins together on the PWB. It is recommended to use the input levels of VREFB $=0.75 \mathrm{~V}$ and $\mathrm{VREFB}=1.25 \mathrm{~V}$ to achieve optimum ADC performance. It is also recommended to apply a common-mode voltage to the input of 1 V .

## clock input

The clock input is designed for 1.8 V or 3.3 V CMOS logic levels (depends on $\mathrm{DR}_{\mathrm{VDD}}$ ) and it is recommended to use standard CMOS logic levels as inputs. The logic threshold internally is set to $\mathrm{DRV}_{\mathrm{DD}} / 2$ or nominally 1.65 V . Since both edges of the clock are used in the switch capacitor architecture, it is important to provide a clock with (ideally) a $50 \%$ duty cycle. The performance variation with clock duty cycle can be examined from Figures 25, 26, 27 and 28.
Clock jitter is also important for performance of the ADC to be maintained. Any clock jitter appears as noise when sampling input frequencies. Clock Jitter reduces the signal to noise ratio (SNR) and is more severe as the input frequency increases. The theoretical SNR limits based on clock jitter can be calculated as follows:

Theoretical SNR ${ }_{\text {(clock jitter) }}$

$$
(\mathrm{dB})=20 \log \left(\frac{1}{2 \times \pi \times \mathrm{F}_{\mathrm{l}} \times \mathrm{CLK}_{(\mathrm{jitter})}}\right)
$$

Where:
$\mathrm{F}_{1}=$ Highest input frequency to the ADC in Hz
$\mathrm{CLK}_{\text {(jitter) }}=$ the amount of jitter on the clock in sec
Therefore for a Nyquist frequency input of 32.5 MHz and a design trying to achieve the most available performance from the ADS5102/3, the clock jitter must be less than 3.98 ps rms. In under sampling applications, the same equations apply and clock jitter becomes more critical and may be the limiting factor in system performance. The aperture jitter of the SHA also contributes to overall jitter. For worst case designs, the jitter of clock and aperture can be considered to add in quadrature, i.e.

$$
\text { Total Jitter }=\text { Square root of }\left(\text { CLK }_{j i t t e r}{ }^{2}+\text { Aperture }_{\text {jitter }}{ }^{2}\right)
$$

The aperture jitter of the ADS5103 is 2 ps rms and at frequencies approaching Nyquist, the total jitter should be accounted for.

## PRINCIPLES OF OPERATION

## digital outputs

The outputs of the ADS5102/3 are also CMOS and are programmable for either 3.3 V or 1.8 V CMOS logic levels. This is controlled by the $\mathrm{DRV}_{\mathrm{DD}}$ supply. Either 3.3 V or 1.8 V can be applied to $\mathrm{DRV}_{\mathrm{DD}}$ with excellent results. The output format is offset binary with D0 (LSB) and D9 (MSB). See Table 1 for output coding with a differential input signal applied. There is a 5.5 clock latency from the sampling to valid data output on D0-D9.
The outputs can be placed into active mode by taking $\overline{\mathrm{OE}}$ low or 3 -state by taking $\overline{\mathrm{OE}}$ high. The timing relations between $\overline{\mathrm{OE}}$ and output bus enable/disable times are shown in the timing diagram (refer to page 7). The capacitive loading on the digital outputs is very important to achieve best performance. The total load capacitance is typically made up of two sources, next stage input capacitance and PWB etch run capacitance. The total capacitance of these two loads should be held to less than 15 pF . If for some reason, this cannot be met, it is recommended to use logic buffers such as ' 244 placed physically very close to the ADC output. This isolates the ADC output from the load capacitance and performance specs are achieved. Another technique is to place a small resistor in series with the outputs. This resistance dampens the current spikes into the capacitive loads and thus improve ADC performance. The value of this resistor varies with sampling rate but generally $22 \Omega$ is a good value. Again this depends on the load capacitance.

The digital output of these devices is offset binary and follows the following format.
Table 1. Output Coding

† Where there is either an internal voltage reference or an external voltage reference applied to the REFT and REFB pins.

## driving the analog input

Since many real world signals are single ended and most modern high speed ADC's employ differential inputs, it is necessary in many cases to perform single ended to differential conversion prior to the ADC. Also, the ADC performs optimally if a differential signal is applied to the inputs. In some cases, signal conditioning is required in the form of the amplification or filtering. The two preferred techniques for driving the ADC input are: 1) With an active amplifier specifically designed to drive ADC's; 2) With an RF transformer.

## driving the analog input with a differential amplifier

Texas Instruments has developed a family of high quality operational amplifiers that have been designed specifically for driving the input stage of modern ADC's. These devices allow for amplification and filtering prior to the ADC. This stage can be used to set the maximum signal voltage to match the full scale input of the ADC. The best solution for driving the ADS5102/3 ADC's is the THS4501 amplifier. Figure 31 shows how to use this device with a gain of 2 . The ADC common mode output voltage can be directly connected to the op amp to provide the proper levels. The THS4501 provides optimum matching of op amp output to the input of the ADS5102/3. This configuration provides signal amplification, filtering, and single-ended to differential conversion. It is recommended to provide de-coupling capacitors of $0.1 \mu \mathrm{~F}$ and $0.001 \mu \mathrm{~F}$ on the CML output. This filters out any high frequency noise prior the ADC input.

## PRINCIPLES OF OPERATION



Figure 31. Driving the ADS5102/3 With Differential Amp (Gain = 2)

## driving the analog input with a transformer

When little or no signal conditioning is required, a simple transformer is an excellent way to drive the input of the ADS5102/3 family. The transformer provides single-ended to differential conversion and at frequencies under 200 MHz produces very little distortion of the incoming signal. Figure 32 shows the preferred circuit diagram for implementing a transformer-coupled input. The signal source is ac-coupled and fed to the primary side of the RF transformer. Since the ADC input must be biased to the correct common mode voltage, the CML output of the ADC is connected to the secondary center tap. It is recommended to provide decoupling capacitors of $0.1 \mu \mathrm{~F}$ and $0.001 \mu \mathrm{~F}$ on the CML output. This filters out any high frequency noise prior the ADC input.


Figure 32. Driving the ADS5102/3 With a Transformer

## PRINCIPLES OF OPERATION



Figure 33. Driving the Analog Inputs

## setting the bias resistor-RBIAS

Each device in this family requires an external resistor be connected from pin 14 to ground. The value of this resistor is determined by which device is being used. Refer to Table 2 for the correct resistor value. This resistor only dissipates less than 1 mW of power. The resistor accuracy of $1 \%$ is adequate.

Table 2. Resistor Value

| DEVICE | RBIAS VALUE | CONNECT FROM |
| :---: | :---: | :---: |
| ADS5103 | $8.25 \mathrm{k} \Omega$ | Pin 14 to AGND |
| ADS5102 | $4.42 \mathrm{k} \Omega$ |  |

## DEFINITION OF SPECIFICATIONS

Analog Input Bandwidth-The analog input frequency at which the spectral power of the fundamental frequency (as determined by the FFT analysis) is reduced by 3 dB .
Aperture Delay—The delay between the 50\% point of the rising edge of the clock and the instant at which the analog input is sampled.
Aperture Uncertainity (Jitter)—The sample-to-sample variation in aperture delay.
Differential Nonlinearity (DNL)—The maximum deviation of any single LSB transition at the digital output from an ideal 1 LSB step at the analog input. Ideally, each transition step is 1 LSB wide. DNL is the measured error from theoretical in step size. A DNL of less than -1 LSB implies no missing codes.

Integral Nonlinearity (INL)—is the summation of the differential nonlinearity errors and indicates the worst case deviation from an best fit straight line that is drawn from 1/2 LSB of the first transition to 1/2 LSB above the last transition. The best fit is determined using the least squares curve fitting method.
Duty Cycle-is the ratio of the clock time high over the full clock period (time high plus time low) and then also the time low over the total clock period. At a given clock rate, these specs define the acceptable duty cycle allowed on the clock.

Sampling Rate (Fs)——The rate at which the converter tested to ensure conversion of analog signals to digital. The maximum rate specified is the rate and which the device is production tested to ensure performance specs are met. Expressed in mega samples per second (MSPS).

Output Propagation Delay—The delay between the $50 \%$ point of the falling edge of clock signal and the time when all output data bits are within valid logic levels.

Offset Error-In an ideal ADC the first transition from 0000000000 should occur at $1 / 2$ LSB above REFB. Offset Error is defined as the difference between this ideal first transition and the voltage level where the first transition actually occurs. Expressed in \% full scale range (\%FSR) but may also be expressed in volts. This can be thought of as shifting the transfer function either left or right along the X-axis.
Overvoltage Recovery Time-The amount of time required for the converter to recover to $0.2 \%$ accuracy after an analog input signal $150 \%$ of full scale is reduced to midscale.
Power Supply Rejection Ratio—The ratio of a change in input offset voltage to a change in power supply voltage.

Total Harmonic Distortion (THD)—The ratio of the peak signal amplitude to the summation of the harmonic components. This is expressed in - dB. THD = 20 Log [input amplitude/(summation of harmonic bins)]. For calculation purposes, the first 7 harmonics are included in the calculations.

Signal To Noise Distortion (SINAD)—The ratio of the rms signal amplitude (set 1 dB below full scale) to rms value of the sum of all other spectral noise and harmonic components, but excluding dc.

Signal to Noise Ratio (SNR)—The ratio of the rms signal amplitude (set at 1 dB below full scale) to the rms value of the the sum of all other spectral components, excluding the first five harmonics and dc. Reported in dB .

Spurious Free Dynamic Range (SFDR)—The difference between the peak amplitude of a fundamental input sine wave and the largest peak spurious component that appears, excluding dc and the input. The peak spurious component may or may not be a harmonic frequency. May be reported in dBc (i.e., degrades as signal levels is lowered), or in dBFS (always related back to converter full scale).

## MECHANICAL DATA

PFB (S-PQFP-G48)


NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS-026

## PACKAGING INFORMATION

| Orderable Device | Status ${ }^{(1)}$ | Package <br> Type | Package <br> Drawing | Pins Package <br> Qty | Eco Plan ${ }^{(2)}$ | Lead/Ball Finish | MSL Peak Temp ${ }^{(3)}$ |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ADS5102IPFB | ACTIVE | TQFP | PFB | 48 | 250 |  <br> no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR |
| ADS5102IPFBG4 | ACTIVE | TQFP | PFB | 48 | 250 |  <br> no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR |
| ADS5103IPFB | ACTIVE | TQFP | PFB | 48 | 250 |  <br> no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR |
| ADS5103IPFBG4 | ACTIVE | TQFP | PFB | 48 | 250 |  <br> no Sb/Br) | CU NIPDAU | Level-2-260C-1 YEAR |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The $\mathrm{Pb}-\mathrm{Free} / \mathrm{Green}$ conversion plan has not been defined.
Pb -Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb -Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS \& no $\mathbf{S b} / \mathrm{Br}$ ): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine ( Br ) and Antimony ( Sb ) based flame retardants ( Br or Sb do not exceed $0.1 \%$ by weight in homogeneous material)
${ }^{(3)}$ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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